



RADIO TEST REPORT

Test Report No. : 29AE0044-HO-01-C

Applicant : Sony Computer Entertainment Inc.
Type of Equipment : Testing Tool
Model No. : DTP-H1500A B
FCC ID : AK8DTPH1500AB
Test regulation : FCC Part 15 Subpart C 2008
Section 15.207, Section 15.247
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test: August 18 to October 3, 2008

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NVLAP LAB CODE: 200572-0

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SECTION 1: Customer information

Company Name	Sony Computer Entertainment Inc.
Brand Name	SONY
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Contact Person	Akiko Tsukada

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	Testing Tool
Model No	DTP-H1500A B
Serial No	SJ0016664: Used for Conducted emission and Spurious emission(Radiated). SJ0016666: Used for Antenna terminal Conducted tests.
Country of Manufacture	Japan
Receipt Date of Sample	August 18, 2008
Condition of EUT	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	No modification by the test lab.

2.2 Product Description

Model No: DTP-H1500A B is the Testing Tool for game machine.

Model No: DTP-H1500A B has a variant model No.: DTP-L1500A B and their radio specification are identical.

Product Specification

Clock frequency in the system	44MHz
Operating Temperature	10-35 deg. C
Power Supply	DC19.5V (AC Adapter: AC100-240V, 50/60Hz)

Radio Specification

Equipment Type	Transceiver
Frequency of Operation	2412-2462MHz
Type of Modulation	DSSS
Bandwidth & Channel spacing	20MHz & 5MHz
Method of frequency generation	Crystal
Power Supply (inner)	DC3.2V
Antenna Type	External antenna
Antenna Gain	5.0dBi max

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2008, final revised on May 19, 2008

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

FCC 15.31 (e)

This EUT provides stable voltage(DC3.2V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.2 Procedures and results

[DSSS and other forms of modulation]

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.2	FCC: Section 15.207 IC: RSS-Gen 7.2.2	Conducted	N/A	[QP] 15.2dB 3.70099MHz, N [AV] 8.9dB 4.00937MHz, L	Complied
2	6dB Bandwidth	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) IC: RSS-210 A8.2(a)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: -	FCC: Section 15.247 (d) IC: RSS-210 A8.5	Conducted/ Radiated	N/A		Complied
5	Power Density	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: -	FCC: Section 15.247 (e) IC: RSS-210 A8.2(b)	Conducted	N/A		Complied
6	Spurious Emission	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d) IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted/ Radiated	N/A	[Tx] 6.5dB 4824.00MHz Ver., Hori., AV [Rx] 6.4dB 576.006MHz QP, Hori.	Complied

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*These tests were performed without any deviations from test procedure except for additions or exclusions.

* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

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3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission	Radiated emission (10m*)				Radiated emission (3m*)			Radiated emission (3m*)	
	150kHz-30MHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	1GHz-18GHz	18GHz-40GHz	
No.1 semi-anechoic chamber (±)	3.7dB	3.1dB	4.4dB	4.2dB	3.2dB	3.8dB	3.9dB	5.9dB	6.1dB	
No.2 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.4dB	4.0dB	5.9dB	6.1dB	
No.3 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.6dB	4.0dB	5.9dB	6.1dB	
No.4 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	3.9dB	3.9dB	5.9dB	6.1dB	

*10m/3m = Measurement distance

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is 3.0dB.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

The mode used for test : [IEEE 802.11b: DSSS]

Test	Mode	Tested frequency
Conducted Emission Spurious Emission	IEEE802.11b Transmitting (Tx) 2Mbps *1)	2412MHz(L) 2437MHz(M) 2462MHz(H)
	IEEE802.11b Receiving (Rx)	2437MHz(M)
6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	IEEE802.11b Transmitting (Tx), 2Mbps *1)	2412MHz(L) 2437MHz(M) 2462MHz(H)
Restricted Band Edge	IEEE802.11b Transmitting (Tx), 2Mbps *1)	2412MHz(L) 2462MHz(H)

*Transmitting duty was 100% on all tests.

*As a result of preliminary check, the formal test was performed as above-mentioned table.

*1) The transmitting data shall be scrambled with the following scramblers and it was transmitted continuously.
[11b]

2Mbps: IEEE Std 802.11(1999) Section 15.2.4

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4.2 Configuration and peripherals

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Detector	: quasi-peak and average detector (IF BW 9 kHz)
Measurement range	: 0.15-30MHz
Test data	: APPENDIX 2
Test result	: Pass

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SECTION 6: Spurious Emission

[Conducted]

Test Procedure

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.

It was measured based on "1. RF antenna conducted test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

The following spectrum analyzer setting was used:

- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2

Test result : Pass

[Radiated]

Test Procedure

It was measured based on "2. Radiated emission test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane.

The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

The result also satisfied with the general limits specified in section FCC 15.209(a) / RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer *1)
Detector	QP: BW 120kHz	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth		AV: RBW:1MHz/VBW: 10Hz

*1) The Spectrum Analyzer was used in 3dB resolution bandwidth.

- The carrier level and noise levels were confirmed at each position of 0 deg., 90 deg., and 180 deg., axes of Antenna to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : APPENDIX 2

Test result : Pass

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SECTION 7: Bandwidth

6dB Bandwidth

Test Procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
It was measured based on "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247 ".
The following spectrum analyzer setting was used:

- Span: 50MHz
- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2
Test result : Pass

99% Occupied Bandwidth

Test Procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
The following spectrum analyzer setting was used:

- Span: Enough width to display 20dB Bandwidth
- RBW: as close to 1% of the Span as is possible without being below 1%
- VBW: Three times of RBW
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2
Test result : Pass

SECTION 8: Maximum Peak Output Power

Test Procedure

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.

It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

Test data : APPENDIX 2

Test result : Pass

SECTION 9: Peak Power Density

[Conducted]

Test Procedure

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.

It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

- Span: 1.5MHz
- RBW: 3kHz
- VBW: 100kHz
- Sweep: 500sec
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2

Test result : Pass

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